

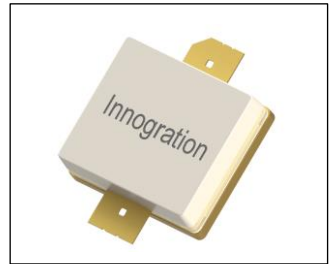


## GaN HEMT 28V, 2450MHz 120W, RF Power Transistor

### Description

The XTAH25120A2C is a 120W GaN HEMT, designed for ISM/RF Energy application within S Band low end, especially at 2.45GHz. It can be used in CW, Pulse and any other modulation modes.

**It is recommended to use paired XTAH25120A2C to deliver >200W in cost effective ways, and offer better thermal management and easier maintenance.**



- Typical 2.4-2.5GHz full band class AB RF Performance with **1pcs device** soldered  
Vds=28V, Idq=110mA, CW

Freq (MHz)	P1dB (dBm)	P1dB (W)	P1dB Eff(%)	P1dB Gain(dB)	P3dB (dBm)	P3dB (W)	P3dB Eff(%)
2400	50.6	114.7	60.7	16.77	51.67	146.9	68
2450	50.45	111.0	65.0	17.49	51.45	139.8	71
2500	50.12	102.9	68.7	18.07	51	126.0	74

Recommended driver: ITEH38007P3 or GTAH35006PD

- Typical 2.4-2.5GHz full band class AB RF Performance with **2pcs devices** soldered  
Vds=28V, Idq=110mA, CW

Freq (MHz)	P1dB (dBm)	P1dB (W)	P1dB Eff(%)	P1dB Gain(dB)	P3dB (dBm)	P3dB (W)	P3dB Eff(%)
2400	53.32	215.0	59.8	16.44	54.21	263.5	65
2450	53.3	214.0	64.3	16.85	54.13	258.8	69
2500	52.87	193.7	66.8	17.37	53.79	239.2	72

Recommended driver: ITEH27010P3 or GTAH35012PD

### Applications

- S band power amplifier
- ISM/RF Energy power amplifier

### Important Note: Proper Biasing Sequence for GaN HEMT Transistors

#### Turning the device ON

1. Set VGS to the pinch-off (VP) voltage, typically -5 V
2. Turn on VDS to nominal supply voltage
3. Increase VGS until IDS current is attained
4. Apply RF input power to desired level

#### Turning the device OFF

1. Turn RF power off
2. Reduce VGS down to VP, typically -5 V
3. Reduce VDS down to 0 V
4. Turn off VGS

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain--Source Voltage	V <sub>DSS</sub>	+150	Vdc
Gate--Source Voltage	V <sub>GS</sub>	-8 to +0.5	Vdc
Operating Voltage	V <sub>DD</sub>	36	Vdc
Maximum gate current	I <sub>gs</sub>	27.2	mA
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Case Operating Temperature	T <sub>c</sub>	+150	°C
Operating Junction Temperature	T <sub>j</sub>	+225	°C



**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA $T_C = 85^\circ\text{C}$ , at $P_{\text{diss}} = 50\text{W}$	$R_{\theta\text{JC}}$	1.6	$^\circ\text{C}/\text{W}$

**Table 3. Electrical Characteristics ( $T_A = 25^\circ\text{C}$  unless otherwise noted)**

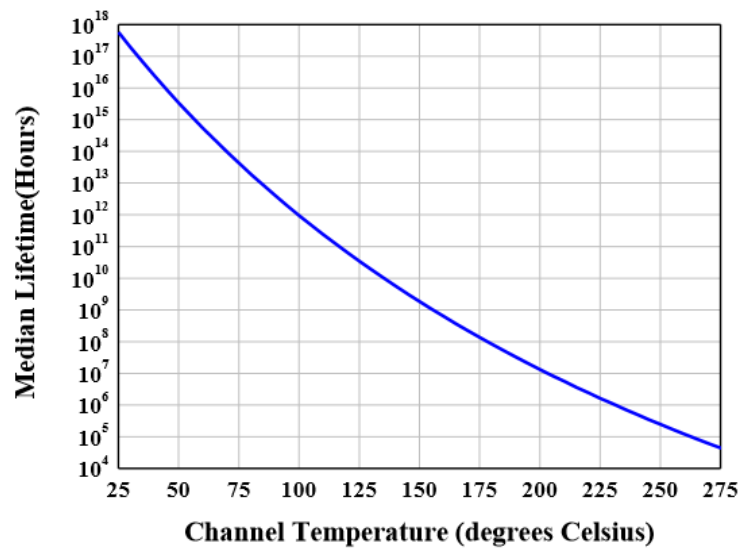
**DC Characteristics ( measured on wafer prior to packaging)**

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{\text{GS}} = -8\text{V}$ ; $I_{\text{DS}} = 27.2\text{mA}$	$V_{\text{DSS}}$		150		V
Gate Threshold Voltage	$V_{\text{DS}} = 10\text{V}$ , $I_{\text{D}} = 27.2\text{mA}$	$V_{\text{GS(th)}}$	-4		-2	V
Gate Quiescent Voltage	$V_{\text{DS}} = 28\text{V}$ , $I_{\text{DS}} = 60\text{mA}$ , Measured in Functional Test	$V_{\text{GS(Q)}}$		-2.3		V

**Ruggedness Characteristics**

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Load mismatch capability	2.5GHz, $P_{\text{out}} = 120\text{W}$ Pulsed CW All phase, No device damages	VSWR		10:1		

**Figure 2: Median Lifetime vs. Channel Temperature**





## XTAH25120A2C single device Typical performance

Figure 3: Network analyzer output S11/S21

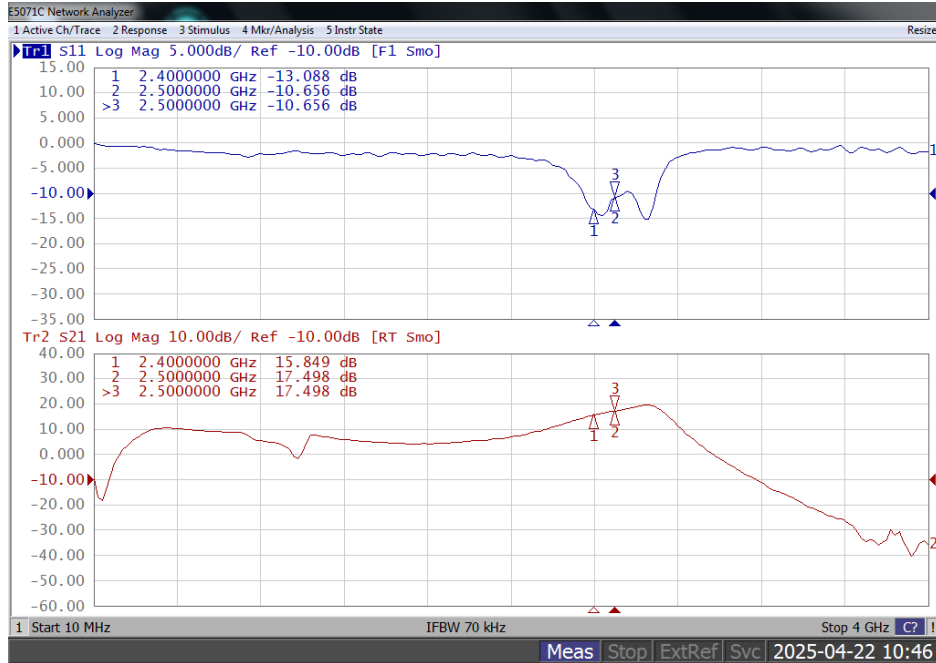


Figure 4: Picture of application board

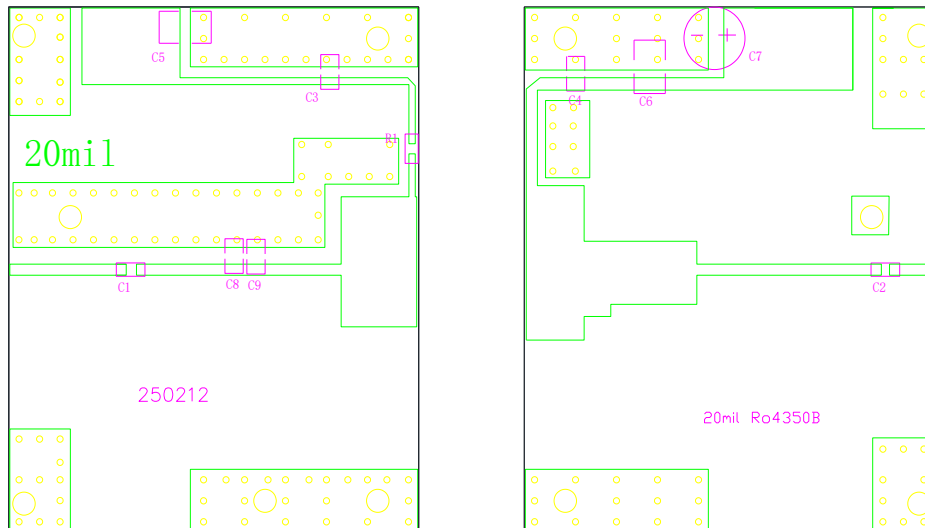


Table 4. Bill of materials of application board (PCB layout upon request)

Designator	Comment	Footprint	Quantity
C1, C2, C3, C4	10 pF	0805	4
C5, C6	10uF/100V	1210	2
C7	470 uF/63V		1
C8, C9	1.0 pF	0603	2
R1	10 $\Omega$	0603	1

## XTAH25120A2C\*2 combination Typical performance

Figure 5: Network analyzer output S11/S21

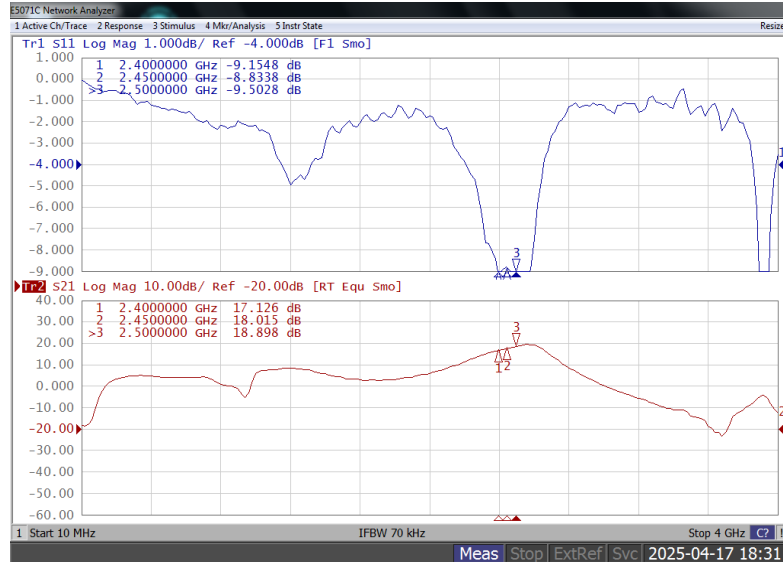


Figure 6: Picture of application board

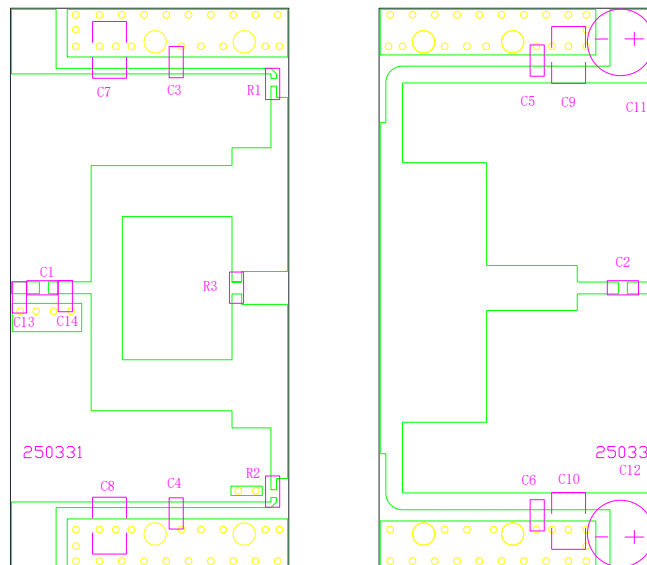
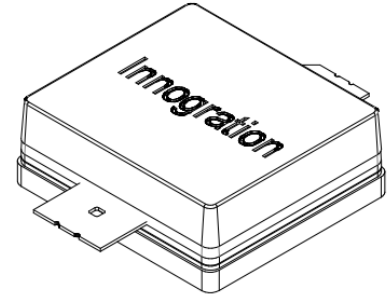
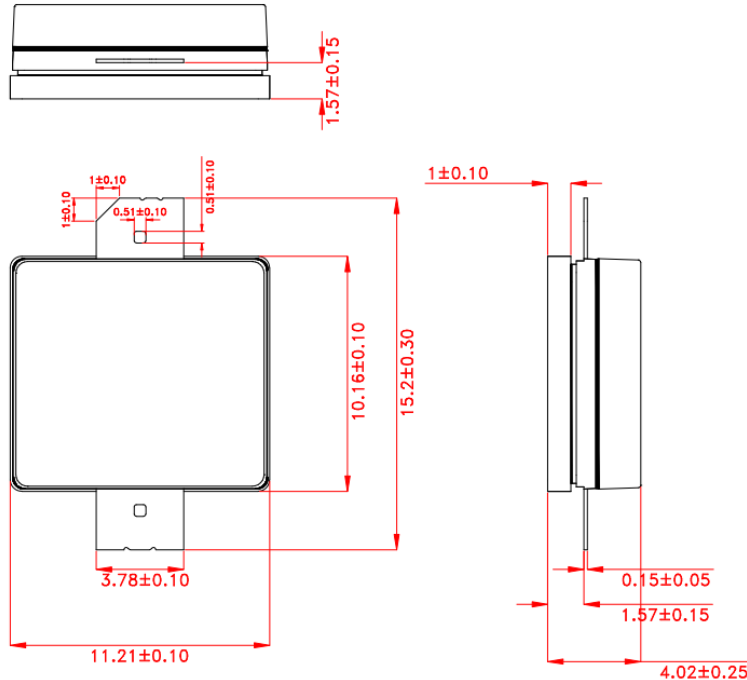


Table 5. Bill of materials of application board (PCB layout upon request)

Designator	Comment	Footprint	Quantity
C1, C2, C3, C4, C5, C6	12 pF	0805	6
C7, C8, C9, C10	10uF/100V	1210	4
C11, C12,	470 uF/63V		2
R1, R2, R3	10 Ω	0603	3
C13	1.0 pF	0603	1
C14	2.0 pF	0603	1



## Package Dimensions (Unit:mm)



Unit:mm

Tolerance  $\pm 0.10$ mm, Except as Noted.

## Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2025/4/22	V1.0	Preliminary Datasheet Creation

Application data based on: LSM-25-06/08

## Notice

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